

## Special Issue

# Fault-Tolerant Digital Circuits: Protection Techniques, CAD Tools and Emerging Applications

### Message from the Guest Editor

Reliability is a growing concern for electronic digital circuits. In this Special Issue, we are interested in exploring new protection techniques for electronic systems, CAD tools to perform reliability tests and novel applications, in different fields, which can benefit from the use of fault-tolerant circuits. These topics include but not limited to:

- New protection techniques for digital circuits
- Fault-tolerant computer architectures
- Error correction codes (ECC) to increase reliability in innovative ways
- Signal and image processing systems with a focus on reliability
- CAD tools and methods to emulate error injection test processes
- Novel applications of fault tolerant digital circuits

Welcome to contribute.

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### Guest Editor

Prof. Dr. Juan Antonio Maestro  
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### Deadline for manuscript submissions

closed (31 March 2021)



## Electronics

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## About the Journal

### Message from the Editor-in-Chief

*Electronics* is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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### Editor-in-Chief

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